

Generation of Spin Defects by Ion Implantation in Hexagonal Boron Nitride

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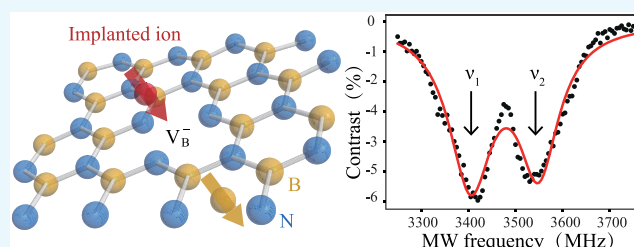


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Supporting Information

ABSTRACT: Optically addressable spin defects in wide-band-gap semiconductors as promising systems for quantum information and sensing applications have recently attracted increased attention. Spin defects in two-dimensional materials are expected to show superiority in quantum sensing due to their atomic thickness. Here, we demonstrate that an ensemble of negatively charged boron vacancies (V_B^-) with good spin properties in hexagonal boron nitride (hBN) can be generated by ion implantation. We carry out optically detected magnetic resonance measurements at room temperature to characterize the spin properties of ensembles of V_B^- defects, showing a zero-field splitting frequency of ~ 3.47 GHz. We compare the photoluminescence intensity and spin properties of V_B^- defects generated using different implantation parameters, such as fluence, energy, and ion species. With the use of the proper parameters, we can successfully create V_B^- defects with a high probability. Our results provide a simple and practicable method to create spin defects in hBN, which is of great significance for realizing integrated hBN-based devices.



1. INTRODUCTION

Solid-state spin defects have attracted widespread attention as promising quantum systems in recent decades¹ and have numerous applications in quantum information^{2,3} and quantum sensing.^{4,5} Some prominent systems have been studied extensively, including the nitrogen vacancy (NV) center^{6–9} and the silicon vacancy center^{10,11} in diamond and the divacancy center^{12,13} and the silicon vacancy center^{14,15} in silicon carbide. Although these defects have many remarkable properties, such as a long spin coherence time at room temperature,¹⁶ there are some intrinsic limitations due to the three-dimensional nature of the materials. For example, it is difficult to prepare spin defects close to the sample surface, which affects the sensitivity of the sensor.¹⁷

Recently, the emergence of spin defects in two-dimensional materials and van der Waals crystals has provided a remedy for the limitations of three-dimensional materials. One of the outstanding materials is hexagonal boron nitride (hBN), which possesses a wide bandgap and a variety of atom-like defects, making hBN a good quantum system for single-photon emitters^{18–24} and spin-addressable systems^{23–27} at room temperature. Currently, most studies of spin defects are focused on the negatively charged boron vacancy (V_B^-) that consists of a missing boron atom that is replaced by an extra electron in the hBN crystal.^{25–35} The V_B^- defects are photostable and exhibit good spin properties at room temperature.²⁵ In addition, the V_B^- defects have a triplet

ground state ($S = 1$) and can be initialized, manipulated, and optically read out at room temperature, showing the potential for spin-based quantum information and sensing applications.^{25,26}

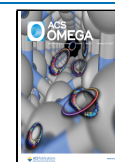
In this context, we demonstrate a new way to generate V_B^- defects in hBN crystals by an ion implantation process using an ion implanter. At present, V_B^- defects can be generated by high-dose neutron irradiation,²⁵ focused ion beam (FIB) implantation,³⁰ femtosecond laser writing,³¹ and high-energy electron irradiation.³² With appropriate energy and fluence for implanted ions, we successfully created ensembles of V_B^- defects using an ion implanter, which exhibit good contrast in the optically detected magnetic resonance (ODMR) results. In addition, we measured the Rabi oscillations and spin–lattice relaxation time (T_1) of the defects (see the [Supporting Information](#)).

In the experiment, we used a commercially available monocrystalline hBN sample purchased from HQ Graphene with a lateral size of ~ 1 mm. Monocrystalline hBN was exfoliated with tape into 10–100 nm thick flakes, which were

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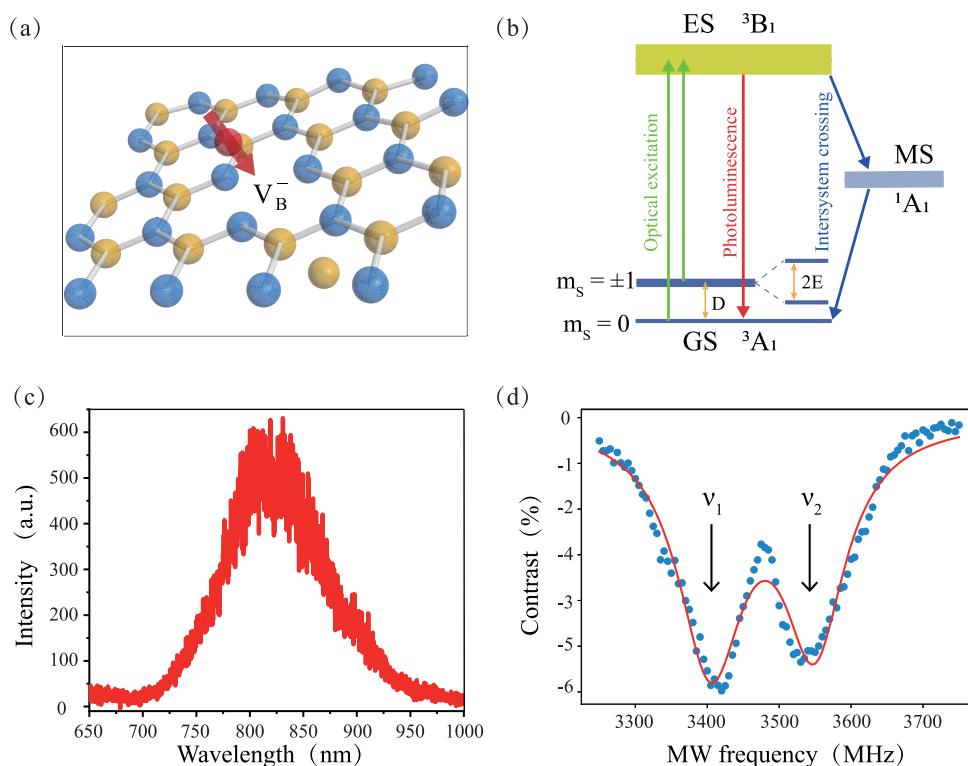


Figure 1. Generation of V_B^- defects in hBN by implanting nitrogen ions with an energy of 30 keV and a fluence of 1×10^{14} ions/cm². (a) Schematic of the ion implantation process. Alternating boron (red) and nitrogen (blue) atoms form the crystalline hexagonal structure of an hBN monolayer. Implanted nitrogen (green) ions knock out boron atoms from the hBN lattice to generate V_B^- defects. (b) Simplified V_B^- energy-level diagram and the transitions among the ground state (3A_1), excited state (3B_1), and metastable state (1A_1). (c) Photoluminescence (PL) spectrum for the implanted sample at room temperature, showing an emission centered at ~ 820 nm. (d) ODMR measurement of the spin defects generated by ion implantation without an external magnetic field. The red line is a fit to a two-Lorentzian function, where $\nu_1 \sim 3405$ MHz and $\nu_2 \sim 3548$ MHz.

later transferred onto a silicon substrate. The sample was then put into an ion implanter (IonImplantation-CETC-M56100), and the hBN flakes were implanted with parallelized ion beams over a large area. Through the ion implantation process, we successfully created V_B^- defects. The process is schematically shown in Figure 1a. The high-energy ions break the B–N bonds in the hBN lattice and knock out boron atoms, leaving behind negatively charged vacancies. The photoluminescence (PL) and spin properties of the defects were characterized using a confocal microscope system combined with a microwave system. We used a 532 nm laser to excite the defects with a laser power of 4.7 mW, used a 0.5 N.A. objective (Olympus) to focus onto the sample, collected the fluorescence utilizing a 9 μ m core-diameter fiber attached to an avalanche photodiode, and used a copper wire with a diameter of 20 μ m placed close to the implanted sample as an antenna to deliver a microwave field.^{28,36}

2. RESULTS AND DISCUSSION

With the setup described above, we first characterized the PL spectrum of an ensemble of defects generated by implanting nitrogen ions with an energy of 30 keV and a fluence of 1×10^{14} ions/cm², as shown in Figure 1c. The implanted samples exhibit strong PL emission ranging from 700 to 1000 nm and a center at approximately 820 nm, which is characteristic of V_B^- centers and consistent with reported V_B^- defects created by neutron irradiation, FIB, and laser writing.^{25,30,31} In addition, the V_B^- defects that we created were stable for an extended period of time at room temperature (see the Supporting Information).

To further verify that the ensemble of defects generated by ion implantation were V_B^- centers, we performed optically detected magnetic resonance (ODMR) measurements at room temperature. ODMR measurements were carried out by scanning the frequency of the microwave field from 3250 to 3750 MHz without an external magnetic field, and the ODMR spectrum was fitted by a two-Lorentzian function, as shown in Figure 1d. The result indicates that the fluorescence signal drops when the microwave field oscillates at $\nu_1 \sim 3405$ MHz and $\nu_2 \sim 3548$ MHz, which is consistent with the ODMR spectra measured for V_B^- defects in previous works.^{25,28} Figure 1b shows that the $m_s = \pm 1$ excited state of the V_B^- center is more likely to return to the $m_s = 0$ ground state through nonradiative intersystem crossing, so the V_B^- spin will be polarized into the $m_s = 0$ ground state under continuous laser excitation. When the microwave frequency is in resonance with the split between the ground state sublevels, electrons in the $m_s = 0$ state will be pumped into the $m_s = \pm 1$ state, leading to a decrease in the fluorescence intensity.²⁸ The V_B^- center has a triplet ground state ($S = 1$) with a zero-field splitting (ZFS) described by the parameters D and E . The resonance frequencies ν_1 and ν_2 in the ODMR spectrum can be represented by $\nu_{2,1} = D/h \pm \sqrt{E^2 + (g\mu_B B)^2}$, where h is the Planck constant, g is the Landé factor, μ_B is the Bohr magneton, and B is the static magnetic field.²⁵ In the absence of external magnetic field, the ZFS parameters D and E are given by $D/h = (\nu_1 + \nu_2)/2$ and $E/h = (\nu_2 - \nu_1)/2$, respectively. In our experiment, we find $D/h = 3475 \pm 5$ MHz and $E/h = 70 \pm 5$ MHz. The V_B^- defects exhibit a good ODMR

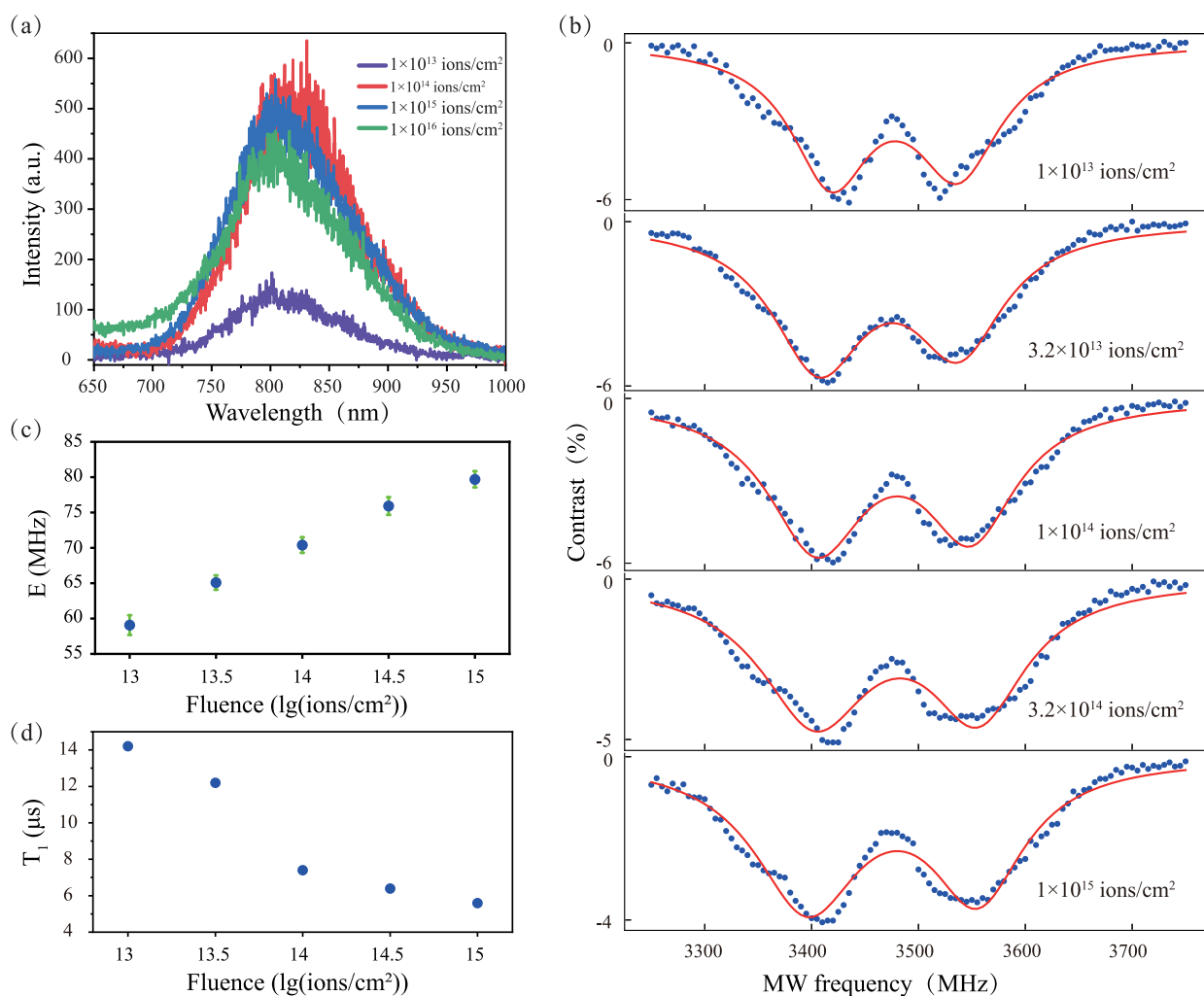


Figure 2. Effects of implantation fluence on the defects. The fluence was varied from 1×10^{13} to 1×10^{16} ions/cm². The energy of the implanted nitrogen ions was fixed at 30 keV. (a) PL spectra at room temperature for the defects created with different fluences. (b) ODMR measurements without an external magnetic field for the defects created with different fluences. (c) The ZFS parameter E as a function of fluence from 1×10^{13} to 1×10^{15} ions/cm². (d) The spin–lattice relaxation time T_1 as a function of fluence from 1×10^{13} to 1×10^{15} ions/cm².

contrast (up to 22%, see the [Supporting Information](#)) and a long relaxation time (up to 17 μs, see the [Supporting Information](#)) at room temperature, showing the promising spin properties for V_B^- defects generated by ion implantation.

Next, we studied the effect of different implantation parameters, such as implantation fluence, energy, and ion species. First, we compared the implantation effect of different fluences. We generated defects by implanting nitrogen ions with the same energy (30 keV) and increasing the fluence from 1×10^{13} to 1×10^{16} ions/cm². [Figure 2a](#) shows a comparison of the room-temperature PL spectra for four defect samples. We find that the intensity of the PL spectra increases with the increasing fluence at low doses. When the fluence increases to 1×10^{14} ions/cm², the PL intensity is shown to decrease slightly, which is similar to that observed for V_{Si} defects in silicon carbide and NV and SiV centers in diamond.^{36–38} This decrease can be considered a saturation phenomenon for the V_B^- defects generated by ion implantation, which might result from the ion-induced damage of the crystal lattices that accumulates in the form of multiple vacancy defects.^{36–38} The ODMR spectra with the two-Lorentzian fitting at different fluences are shown in [Figure 2b](#). The measurements were carried out without an external magnetic field at room

temperature. We find that the ZFS parameter D is stable at ~ 3475 MHz (see the [Supporting Information](#)), while the ZFS parameter E increases almost linearly with the fluence ranging from 1×10^{13} to 1×10^{15} ions/cm², as shown in [Figure 2c](#). Nevertheless, when the fluence reaches 1×10^{16} ions/cm², the ZFS parameter D is no longer stable and varies from 3460 to 3520 MHz, and E is no longer linear (see the [Supporting Information](#)). Furthermore, we measured the spin–lattice relaxation times T_1 of the defects, as shown in [Figure 2d](#), which were found to be negatively correlated with the implantation fluence. The dependence of E and T_1 on fluence can be attributed to the increasing crystal damage with the increasing fluence. Damage due to ion implantation can give rise to local strain fields,³⁹ which have an effect on electron spin transitions. The strain field in hBN is mainly manifested as transverse strain when the damage is not very large,^{40,41} and the effect of transverse strain, as stated in ref 42, is equivalent to a modification of E . The more severe the damage, the larger the transverse strain and thus the larger the transverse splitting. Meanwhile, the damage can deteriorate the spin and optical coherence properties of defects,⁴³ which suggests that more severe damage will lead to a shorter T_1 .

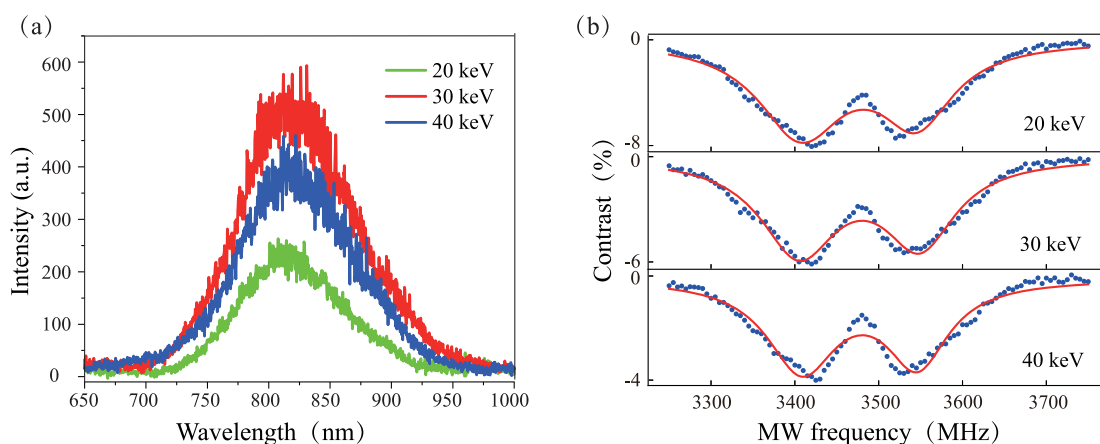


Figure 3. Effects of the energy of the implanted nitrogen ions on the defects. The energy was varied from 20 to 40 keV. The implantation fluence was fixed at 1×10^{14} ions/cm². (a) PL spectrum at room temperature for the defects created with different energies. (b) ODMR measurements without an external magnetic field for the defects created with different energies.

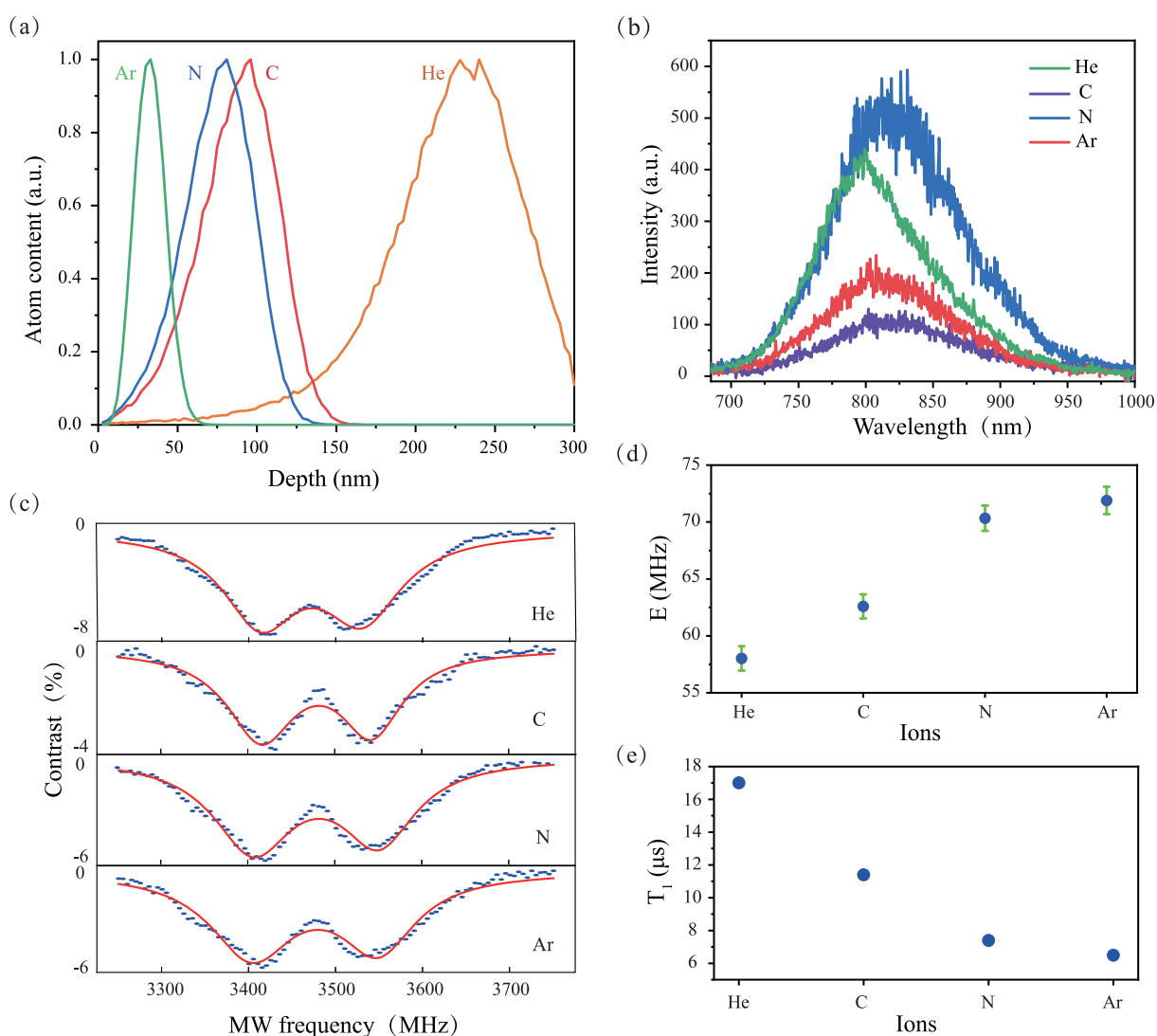


Figure 4. Effects of different implanted ion species on the defects. The implantation fluence was fixed at 1×10^{14} ions/cm², and the energy was fixed at 30 keV. (a) SRIM simulation of the defect distribution with depth generated by implanting different ions (He, C, N, and Ar). (b) PL spectra at room temperature for the defects created with different ions. (c) ODMR measurements without an external magnetic field for the defects created with different ions. (d) The ZFS parameter E varies with different ions. (e) The spin-lattice relaxation time T_1 varies with different ions.

Then, to compare the implantation effect of different energies, we generated defects by implanting nitrogen ions with the same fluence (1×10^{14} ions/cm²) and varying energies from 20 to 40 keV. Figure 3a shows a comparison of the PL spectra measured for these defect samples, and Figure 3b shows a comparison of the ODMR spectra measured at room temperature. We can see that different energies mainly affect the PL intensity but have almost no effect on the spin properties of the V_B^- defects. The PL spectrum for the V_B^- defects generated at an energy of 30 keV displays a higher intensity than those of V_B^- defects generated at other energies, while the ODMR spectra of the V_B^- defects generated at different energies display the same resonance frequency, i.e., the same ZFS parameters D and E . Additionally, we find that the spin–lattice relaxation times T_1 scarcely change with the implantation energies (see the Supporting Information). Because our hBN samples are 10–100 nm thick flakes, ions can easily penetrate the flakes rather than remain in the samples, even at low energy. Although the implantation energies are different, the damage due to ion implantation with the same ion species and fluence is similar. Therefore, the implantation energy does not affect the spin properties of the defects.

Finally, to compare the implantation effect of different ion species, we generated defects by implanting nitrogen, argon, helium, and carbon ions with the same fluence (1×10^{14} ions/cm²) and energy (30 keV). We simulate the theoretical distribution of the V_B^- defects with a depth created by different ions using a stopping-and-range-of-ions-in-matter (SRIM) simulation, as shown in Figure 4a. The result indicates that the number of generated defects and the penetration depth are obviously different for different ions. Argon ions are more likely to create shallow defects, while helium ions can be used to create defects in thicker samples. Figure 4b shows a comparison of the PL spectra measured for these samples at room temperature, from which we can see that the sample implanted using nitrogen ions has the highest PL intensity. Figure 4c shows the ODMR spectra for the defects generated by different implantation ions, indicating that they all have spin properties. We find that when we implant different ions, the ZFS parameter D is stable at ~ 3475 MHz (see the Supporting Information), while the ZFS parameter E is different, which is similar to implantation with different fluences. The difference in the ZFS parameter E is shown in Figure 4d, showing that the ZFS parameter E increases as the ion radius increases. Additionally, the spin–lattice relaxation times T_1 for the defects decrease as the ion radius increases, as shown in Figure 4e. Similar to the dose-dependent relationship mentioned above, the dependence of E and T_1 on the ion species can also be attributed to crystal damage. With the increasing atomic number, the damage increases due to the larger collision cross-section; thus, E increases and T_1 decreases.

3. CONCLUSIONS

We successfully generated optically active V_B^- defects by ion implantation in hBN. There are also several other ways to generate V_B^- defects, such as the neutron irradiation method, the FIB method, the laser writing method, and the electron irradiation method. All these methods have their own advantages and disadvantages. For example, the neutron irradiation method is the primary way to generate V_B^- defects, but it needs to be carried out in a nuclear reactor, which is not very convenient and slightly expensive. Comparatively, the ion

implantation method is convenient and inexpensive because the ion implanter is commercially available. The FIB method allows for the patterning of arrays of spin defects due to its controllability and good positioning. This is the advantage of this method. However, to the best of our knowledge, the ion source often used for commercial FIBs is Ga, and the use of other ion sources is rare. In contrast, the ion implanter has a variety of available ion sources (He⁺, C⁺, N⁺, Ar⁺, etc.) and, moreover, the ion implantation method can be used to create V_B^- defects over a large scale. The laser writing method is simple and flexible, as it can be conducted in an ambient environment with no vacuum requirement. However, the required femtosecond laser pulse has a relatively large energy and is possibly destructive toward the sample. In comparison, the ion implantation method is gentle and results in little damage to the sample. In addition, the electron irradiation method makes it possible to avoid the clustering of defects, but it requires very high electron energy (2 MeV). Relatively, the ion implantation method needs only a relatively low ion energy (30 keV). Therefore, our ion implantation method will be a good supplement to all the above-mentioned methods.

Our results show that the implantation parameters, such as fluence, energy, and ion species, have clear effects on the PL intensity and spin properties of ion implantation-generated V_B^- defects. Therefore, we can create good ensembles of V_B^- defects with a high probability by adjusting the fluence (1×10^{14} ions/cm²) and the energy (30 keV) of the implanted nitrogen ions. The V_B^- defects exhibit a good ODMR contrast at room temperature, which is important for spin-addressable systems. Furthermore, we find that the defects created by implanting helium ions with an energy of 30 keV and a fluence of 1×10^{14} ions/cm² have the longest spin–lattice relaxation time of 17 μ s at room temperature, which is comparable to that achieved for defects created by neutron irradiation.^{26,27} Our work provides a simple and practicable method for the controllable engineering of spin defects in hBN and paves the way for integrated quantum information and sensing applications.

■ ASSOCIATED CONTENT

Supporting Information

The Supporting Information is available free of charge at <https://pubs.acs.org/doi/10.1021/acsomega.1c04564>.

Additional data, PL stability, and probability of generating a V_B^- center (PDF)

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Notes

The authors declare no competing financial interest.

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